

# Detection of Light: Exercise 3

Set: Fri 16th Feb 2017,

Due: Fri 23rd Feb 2017

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## 1 Carrier Mobility [2 marks]

- a Calculate the conductivity of intrinsic Si at room temperature ( $T=293\text{K}$ ). What is the fractional contribution of holes to this value?

(Take the intrinsic carrier density at this temperature to be  $n_i = 4.8 \times 10^9 \text{ cm}^{-3}$  and the relative mobilities of electrons and holes to be  $\mu_n = 1.35 \times 10^3 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ ,  $\mu_p = 480 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  respectively.)

[1 mark]

- b What is the electron mobility in the same photodetector cooled to  $T=150\text{K}$ ? State the physical reason for this temperature dependence.

[1 mark]

## 2 Design of an intrinsic photoconductor [8 marks]

Consider an intrinsic silicon photoconductor operating at  $1 \mu\text{m}$  and constructed as shown in Fig. 1. Let its surface area  $w = l = 1 \text{ mm}$  in a square pixel configuration, operating at room temperature. Assume the detector breaks down when the bias voltage,  $V_b$ , exceeds  $50 \text{ mV}$ .

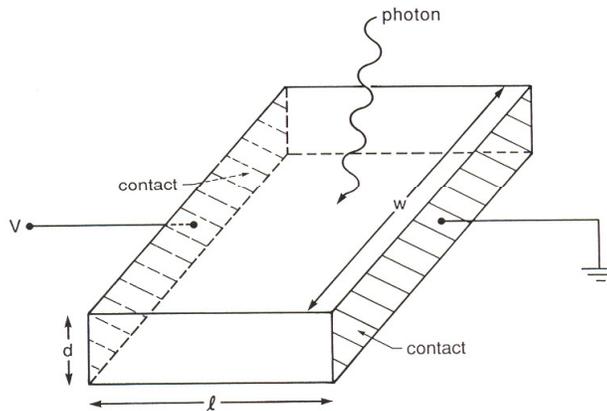


Figure 1: Photoconductor with transverse contacts.

- a The minimum detector thickness required for good quantum efficiency corresponds to one absorption length (photon mean free path length) in the material.
- i) Use the data in Fig. 2 to estimate the minimum detector thickness  $d$  for this detector. What is the corresponding quantum efficiency  $\eta$  of this detector, if reflection is neglected?
- ii) What is a more realistic value of  $\eta$ , if reflection is now taken into account? Assume normal photon incidence on the detector surface and a refractive index for Si of  $n = 3.4$ .

[2 marks]

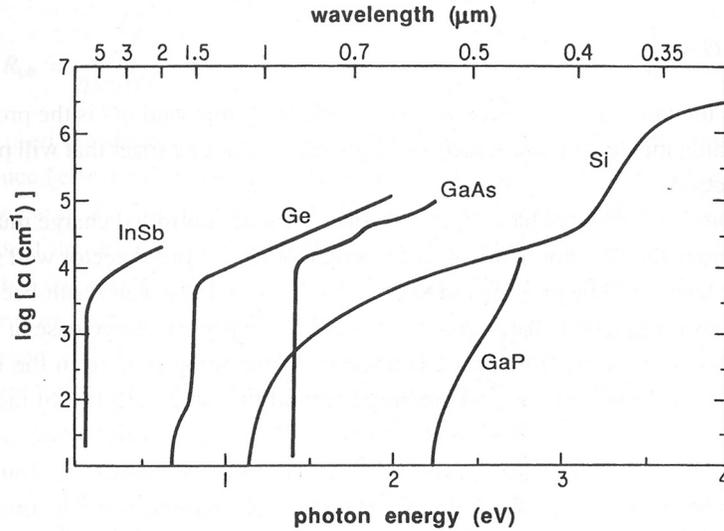


Figure 2: Linear absorption coefficients  $a$  for various semiconductors (on  $\log_{10}$  scale).

- b Calculate the responsivity  $S$  using your value of  $\eta$  in part a.ii, explicitly stating the units of your answer. The recombination time for Si under the given conditions is  $\tau = 1 \times 10^{-4}$  s. Assume the detector is operated at 10 mV below the breakdown voltage. What is the probability of any given photon reaching the detector contact?

[2 marks]

- c Calculate the dark resistance, and hence the dark current of our detector. Compare this to the photo-current obtained when illuminated by an astrophysical source with a photon flux of  $\phi = 10^5 \gamma/s$ .

What do you notice? Why does your result *not* rule out this photoconductor for use as a detector?

(Again, take the electron concentration in Si to be  $n_i = 4.8 \times 10^9 \text{ cm}^{-3}$ .)

[2 marks]

- d Calculate the signal-to-noise ratio our photoconductor obtains for a 0.5s exposure of the source in part c), assuming only thermal Johnson (kTC) and G-R noise sources. State the factor limiting detector performance in this scenario, and suggest how this may be improved.

[2 marks]